





30V P-CHANNEL ENHANCEMENT MODE MOSFET

Product Summary

V _{(BR)DSS}	Max R _{DS(on)}	Max I _D T _A = 25°C	
-30V	75mΩ @ V _{GS} = -10V	-3.8A	
-307	100mΩ @ $V_{GS} = -4.5V$	-3.3A	

Description

This MOSFET utilizes a unique structure that combines the benefits of low on-resistance with fast switching speed, making it ideal for high-efficiency power management applications.

Applications

- DC DC converters
- Power management functions
- Disconnect switches
- Motor control

Features

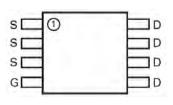
- · Fast switching speed
- Low on-resistance
- Low threshold
- Low gate drive
- Totally Lead-Free & Fully RoHS compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)
- Qualified to AEC-Q101 Standards for High Reliability

Mechanical Data

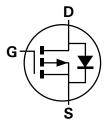
- Case: MSOP8
- Case Material: Molded Plastic, UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminals: Matte Tin Finish; Solderable per MIL-STD-202, Method 208 ³
- Weight: 0.028 grams (approximate)







Top View



Equivalent Circuit

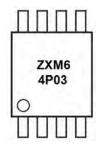
Ordering Information (Note 4)

Product	Marking	Reel size (inches)	Tape width (mm)	Quantity per reel
ZXM64P03XTA	ZXM64P03	7	12	1,000 Units

Notes:

- 1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS) & 2011/65/EU (RoHS 2) compliant.
- 2. See http://www.diodes.com for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.
- 3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.
- 4. For packaging details, go to our website at http://www.diodes.com.

Marking Information



ZXM64P03 = Product Type Marking Code

Maximum Ratings (@T_A = +25°C, unless otherwise specified.)

Characteristic			Symbol	Value	Units
Drain-Source Voltage			V_{DSS}	-30	V
Gate-Source Voltage			V_{GS}	±20	V
Continuous Drain Current	V _{GS} = 4.5V	$T_A = +25$ °C (Note 5) $T_A = +70$ °C (Note 5)	I _D	-3.8 -3.0	А
Pulsed Drain Current (Note 7)			I _{DM}	-1.9	A
Continuous Source Current (Body Diode) (Note 6)			Is	-2.3	A
Pulsed Source Current (Body	Diode) (Note 7	7)	I _{SM}	-19	A

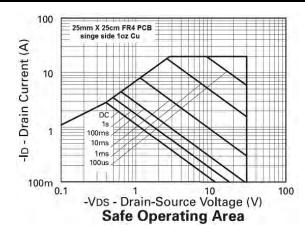
Thermal Characteristics (@T_A = +25°C, unless otherwise specified.)

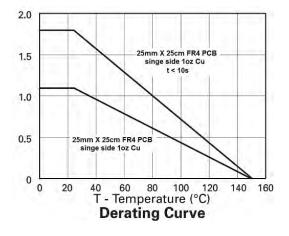
Characteristic	Symbol	Value	Unit
Power Dissipation (Note 5)	Pn	1.1	W
Linear Derating Factor	- 5	8.8	mW/°C
Power Dissipation (Note 6) Linear Derating Factor	P _D	1.8 14.4	W mW/°C
Thermal Resistance, Junction to Ambient (Note 5)	R _{0JA}	113	°C/W
Thermal Resistance, Junction to Ambient (Note 6)	$R_{ heta JA}$	70	°C/W
Thermal Resistance, Junction to Ambient (Note 8)	$R_{ heta JL}$	39.8	°C/W
Operating and Storage Temperature Range	T _J , T _{STG}	-55 to +150	°C

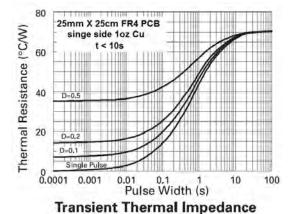
Notes:

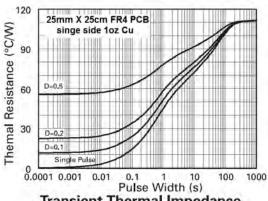
- 5. For a device surface mounted on 25mm x 25mm FR4 PCB with high coverage of single sided 1oz copper, in still air conditions
- 6. For a device surface mounted on FR4 PCB measured at t ≤10 secs.
- 7. Repetitive rating pulse width limited by pulse current limited by maximum junction temperature.
- 8. Thermal resistance from junction to solder-point (at the end of the Drain lead).

Thermal Characteristics













Electrical Characteristics (@T_A = +25°C, unless otherwise specified.)

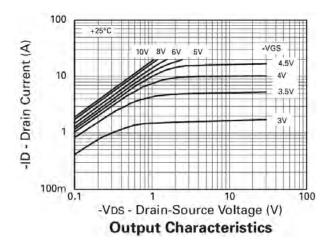
Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition
OFF CHARACTERISTICS						
Drain-Source Breakdown Voltage	BV _{DSS}	-30		1	V	$I_D = -250 \mu A, V_{GS} = 0 V$
Zero Gate Voltage Drain Current	I _{DSS}			-1	μΑ	$V_{DS} = -30V, V_{GS} = 0V$
Gate-Source Leakage	I _{GSS}	_	_	±100	nA	$V_{GS} = \pm 20V, V_{DS} = 0V$
ON CHARACTERISTICS						
Gate Threshold Voltage	V _{GS(th)}	-1.0			٧	$I_D = -250 \mu A$, $V_{DS} = V_{GS}$
Static Drain-Source On-Resistance (Note 9)	D			75	mΩ	$V_{GS} = -10V, I_D = -2.4A$
Static Dialif-Source On-Resistance (Note 9)	R _{DS} (ON)	_	_	100		V _{GS} = -4.5V, I _D = -1.2A
Forward Transconductance (Notes 9 and 11)	g _{fs}	2.3		_	S	$V_{DS} = -10V, I_{D} = -1.2A$
Diode Forward Voltage (Note 9)	V_{SD}	_	_	-0.95	V	$T_J = +25$ °C, $I_S = -2.4$ A, $V_{GS} = 0$ V
Reverse Recovery Time (Note 11)	t _{rr}	_	30.2	_	ns	$T_J = +25^{\circ}C$, $I_F = -2.4A$,
Reverse Recovery Charge (Note 11)	Q_{rr}	_	27.8	_	nC	di/dt = 100A/μs
DYNAMIC CHARACTERISTICS (Note 11)						-
Input Capacitance	C _{iss}		825			V _{DS} = -25V, V _{GS} = 0V f = 1.0MHz
Output Capacitance	Coss	_	250	_	pF	
Reverse Transfer Capacitance	C_{rss}		80	_		
Turn-On Delay Time (Note 10)	t _{d(on)}	_	4.4			V_{DD} = -15V, I_D = -2.4A, R_G = 6.2 Ω , R_D = 6.2 Ω (Refer to test circuit)
Turn-On Rise Time (Note 10)	t _r		6.2	_		
Turn-Off Delay Time (Note 10)	t _{d(off)}	_	40	_	ns	
Turn-Off Fall Time (Note 10)	t _f	_	29.2	_		
Total Gate Charge (Note 10)	Q_q	_	_	46	$V_{DS} = -24V, V_{GS} = -10V,$	
Gate-Source Charge (Note 10)	Q_{gs}	_		9	nC	I _D = -2.4A (Refer to test circuit)
Gate-Drain Charge (Note 10)	Q _{gd}	_	_	11.5		

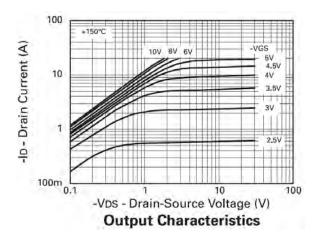
Notes:

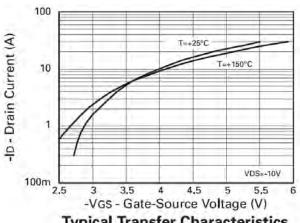
- 9. Measured under pulsed conditions. Pulse width = $300\mu s$. Duty cycle $\leq 2\%$.
- Mitching characteristics are independent of operating junction temperature.
 For design aid only, not subject to production testing.

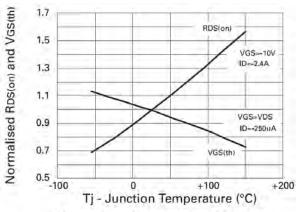


Typical Characteristics

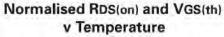


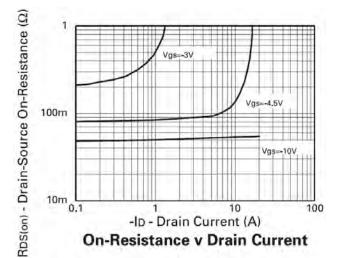


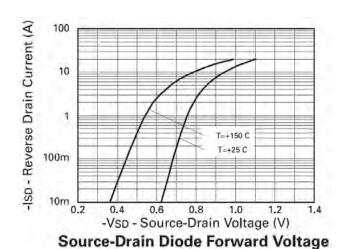




Typical Transfer Characteristics

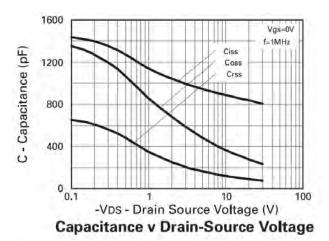


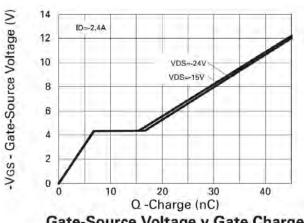






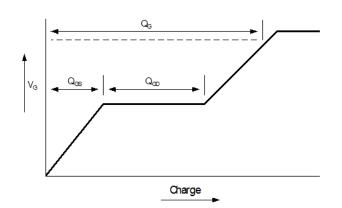
Typical Characteristics - continued



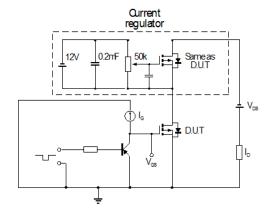


Gate-Source Voltage v Gate Charge

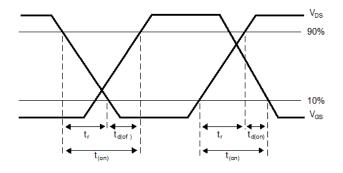
Test Circuits



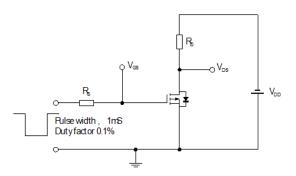
Basic gate charge waveform



Gate charge test circuit



Switching time waveforms

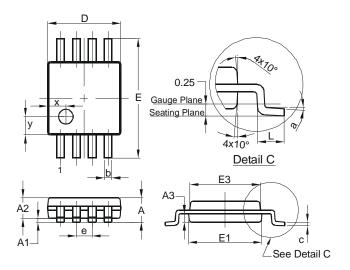


Switching time test circuit



Package Outline Dimensions

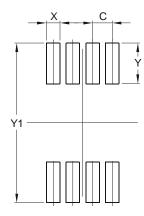
Please see AP02002 at http://www.diodes.com/datasheets/ap02002.pdf for latest version.



MSOP-8					
Dim	Min	Max	Тур		
Α	-	1.10	-		
A 1	0.05	0.15	0.10		
A2	0.75	0.95	0.86		
A3	0.29	0.49	0.39		
b	0.22	0.38	0.30		
C	0.08	0.23	0.15		
D	2.90	3.10	3.00		
Е	4.70	5.10	4.90		
E1	2.90	3.10	3.00		
E3	2.85	3.05	2.95		
е	-	-	0.65		
L	0.40	0.80	0.60		
а	0°	8°	4°		
X	-	-	0.750		
у	-	-	0.750		
All Dimensions in mm					

Suggested Pad Layout

Please see AP02001 at http://www.diodes.com/datasheets/ap02001.pdf for the latest version.



Dimensions	Value (in mm)		
С	0.650		
Х	0.450		
Y	1.350		
Y1	5.300		





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